

<b>Notice of References Cited</b>		Application/Control No. 10/025,567	Applicant(s)/Patent Under Reexamination NASH ET AL.
		Examiner Phuong Huynh	Art Unit 1644

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	U	Kuby et al, Immunology, second edition, pages 85-96, 1994.
	V	Abaza et al, J of Protein Chemistry 11(5): 433-444, 1992.
	W	Sugita-Konishi et al, Biosci Biotechnol Biochem 60(5): 886-8, May 1996.
	X	Yokoyama et al, Vaccine 16(4): 388-93, Feb 1998.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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